

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,044	CHEN, CHUNG	-HUI
Examiner	Art Unit	
Long Nguyen	2816	

	SEARCHED					
Class	Subclass	Date	Examiner			
327	198-203, 208, 210-212,	3/17/05	LN			
	214,215,					
365	154,156	<b>V</b>	$\checkmark$			
updark	above	8/2/05	in			
327	208,217,	8/24/05	in			
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
(327/199-203,210-212, 219,225) (See print out)	8/24/-5	· Cm			
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